Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/825,260	CHAN ET AL.	
Examiner	Art Unit	
Shane Bomar	3672	

SEARCHED				
Class	Subclass	Date	Examiner	
166	312, 90.1, 242.2, 222, 223	1/5/2006	TSB	
166	updated	4/20/06	AB	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
·-				
Interference history pr	search intout	4/20/06	ASB	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor name search	1/5/2006	тѕв
166/311 (text search only - see history printout)	1/5/2006	TSB
EAST text search (all databases - see history printout)	1/5/2006	TSB